MITSUBISHI SEMICONDUTOR <GaAs FET>

MGF4953B

SUPER LOW NOISE InGaAs HEMT (Leadless Ceramic Package)

DESCRIPTION

The MGF4953B super-low noise HEMT (High Electron Mobility Transistor) is designed for use in K band amplifiers.

The lead-less ceramic package assures minimum parasitic losses.

FEATURES

Low noise figure @ f=20GHz NFmin. = 0.55dB (Typ.)

High associated gain

@ f=20GHz

Gs = 10.5dB (Typ.)

APPLICATION

C to K band low noise amplifiers

QUALITY GRADE

GG

RECOMMENDED BIAS CONDITIONS

 $V_{DS}=2V$, $I_{D}=10mA$

ORDERING INFORMATION

Tape & reel 3000pcs./reel

Outline Drawing

Fig.1

MITSUBISHI Proprietary

Not to be reproduced or disclosed without permission by Mitsubishi Electric

ABSOLUTE MAXIMUM RATINGS (Ta=25°C)

Symbol	Parameter	Ratings	Unit
V_{GDO}	Gate to drain voltage	-4	V
V_{GSO}	Gate to source voltage	-4	V
I _D	Drain current	60	mA
PT	Total power dissipation	50	mW
T _{ch}	Channel temperature	125	°C
T _{stg}	Storage temperature	-65 to +125	°C

Keep Safety first in your circuit designs! Mitsubishi Electric Corporation puts the maximum effort into making semiconductor products better and more reliable, but there is always the possibility that trouble may occur with them. Trouble with semiconductors may lead to personal injury, fire or property damage. Remember to give due consideration to safety when making your circuit designs, with appropriate measure such as (I) placement of substitutive, auxiliary circuits, (ii) use of non-flammable material or (iii) prevention against any malfunction or mishap.

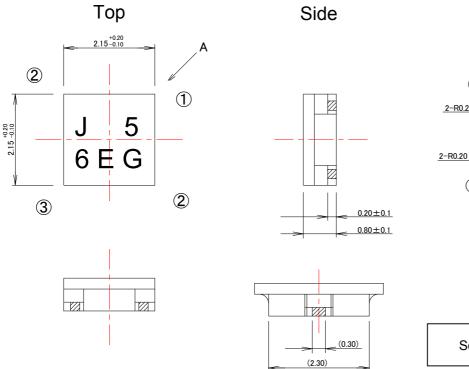
ELECTRICAL CHARACTERISTICS (Ta=25°C)

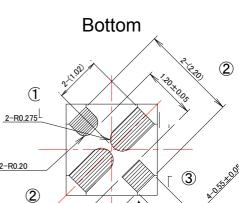
Synbol	Parameter	Test conditions	Limits		Unit	
			MIN.	TYP.	MAX	
$V_{(BR)GDO}$	Gate to drain breakdown voltage	I _G =-10μA	-3			V
I _{GSS}	Gate to source leakage current	V _{GS} =-2V,V _{DS} =0V			50	μΑ
I _{DSS}	Saturated drain current	V _{GS} =0V,V _{DS} =2V	15		60	mA
V _{GS(off)}	Gate to source cut-off voltage	V _{DS} =2V,I _D =500μA	-0.1		-1.5	V
Gs	Associated gain	V _{DS} =2V,I _D =10mA	9.0	10.5		dB
NFmin.	Minimum noise figure	f=20GHz		0.55	0.80	dB

(1/5)

Unit: mm

Fig.1



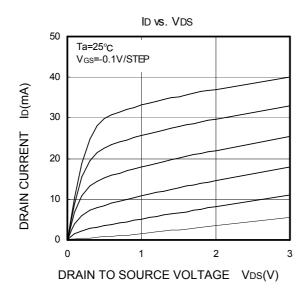


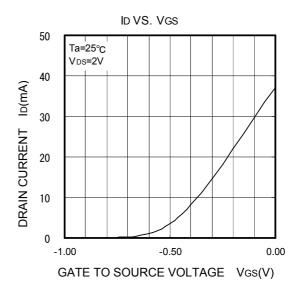
Square shape electrode is Drain

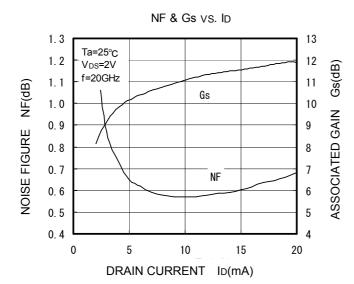
- 1 Gate
- ② Source
- 3 Drain

from "A" side view

TYPICAL CHARACTERISTICS (Ta=25°C)







SUPER LOW NOISE InGaAs HEMT (Leadless Ceramic Package)

S PARAMETERS

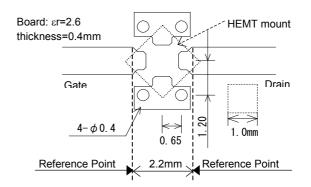
(VDS=2V,ID=10mA, Ta=25°C)

Freq.	S	11	S	21	S12		S22	
(GHz)	(mag)	(ang)	(mag)	(ang)	(mag)	(ang)	(mag)	(ang)
1	0.989	-13.0	4.537	165.8	0.014	78.9	0.637	-9.7
2	0.973	-25.9	4.502	152.9	0.028	71.8	0.629	-19.6
3	0.949	-38.7	4.472	140.4	0.041	62.7	0.621	-29.2
4	0.926	-52.0	4.460	127.3	0.054	53.2	0.608	-39.0
5	0.890	-64.9	4.431	114.9	0.066	44.4	0.592	-48.2
6	0.828	-81.1	4.394	99.8	0.076	33.4	0.539	-60.1
7	0.776	-95.6	4.311	86.3	0.085	24.1	0.505	-70.2
8	0.723	-110.6	4.230	73.2	0.093	15.2	0.469	-80.4
9	0.662	-126.6	4.094	59.9	0.099	5.4	0.423	-90.7
10	0.605	-142.6	3.943	47.4	0.102	-4.0	0.368	-100.2
11	0.551	-158.2	3.826	35.4	0.102	-12.9	0.318	-108.8
12	0.514	-174.5	3.740	23.7	0.100	-19.7	0.279	-116.3
13	0.488	167.0	3.622	11.2	0.099	-28.1	0.232	-126.2
14	0.486	149.0	3.572	-1.1	0.098	-32.1	0.203	-138.3
15	0.480	131.8	3.512	-12.6	0.094	-38.4	0.169	-148.1
16	0.509	113.0	3.425	-26.2	0.099	-43.0	0.148	-175.1
17	0.536	95.1	3.349	-39.1	0.099	-49.9	0.133	157.1
18	0.569	78.2	3.226	-52.1	0.100	-58.5	0.132	120.7
19	0.609	62.7	3.091	-66.1	0.099	-66.5	0.160	92.2
20	0.642	47.3	2.934	-79.2	0.096	-75.2	0.204	67.8
21	0.674	34.3	2.752	-91.8	0.091	-83.8	0.250	50.6
22	0.707	21.1	2.617	-104.8	0.089	-92.5	0.293	37.0
23	0.742	9.2	2.471	-117.4	0.082	-102.8	0.350	23.8
24	0.753	-2.2	2.307	-130.2	0.081	-111.9	0.390	13.5
25	0.775	-12.5	2.139	-142.4	0.072	-118.9	0.430	2.4
26	0.803	-22.5	2.008	-155.0	0.069	-135.9	0.474	-5.7

NOISE PARAMETERS (VDS=2V,ID=10mA, Ta=25°C)

(120 21,12 1011), 10							
Freq.	ГС	opt	Rn	NFmin			
(GHz)	(mag)	(ang)		(dB)			
18	0.358	-137.2	0.12	0.51			
20	0.372	-91.0	0.14	0.55			
22	0.390	-47.7	0.63	0.77			
24	0.417	-14.9	1.05	1.05			
26	0.473	10.5	1.26	1.25			

Note) Rn is normalized by 50ohm



SUPER LOW NOISE InGaAs HEMT (Leadless Ceramic Package)

Requests Regarding Safety Designs

Mitsubishi Electric constantly strives to raise the level of its quality and reliability. Despite these concerted efforts, however, there will be occasions when our semiconductor products suffer breakdowns, malfunctions or other problems. In view of this reality, it is requested that every feasible precaution be taken in the pursuit of redundancy design, malfunction prevention design and other safety-related designs, to prevent breakdowns or malfunctions in our products from resulting in accidents involving people, fires, social losses or other problems, thereby upholding the highest levels of safety in the products when in use by customers.

Matters of Importance when Using these Materials

- 1. These materials are designed as reference materials to ensure that all customers purchase Mitsubishi Electric semiconductors best suited to their specific use applications. Please be aware, however, that the technical information contained in these materials does not comprise consent for the execution or use of intellectual property rights or other rights owned by Mitsubishi Electric Corporation.
- 2. Mitsubishi Electric does not assume responsibility for damages resulting from the use of product data, graphs, charts, programs, algorithms or other applied circuit examples described in these materials, or for the infringement of the rights of third-party owners resulting from such use.
- 3. The data, graphs, charts, programs, algorithms and all other information described in these materials were current at the issue of these materials, with Mitsubishi Electric reserving the right to make any necessary updates or changes in the products or specifications in these materials without prior notice. Before purchasing Mitsubishi Electric semiconductor products, therefore, please obtain the latest available information from Mitsubishi Electric directly or an authorized dealer.
- 4. Every possible effort has been made to ensure that the information described in these materials is fully accurate. However, Mitsubishi Electric assumes no responsibility for damages resulting from inaccuracies occurring within these materials.
- 5. When using the product data, technical contents indicated on the graphs, charts, programs or algorithms described in these materials, assessments should not be limited to only the technical contents, programs and algorithm units. Rather, it is requested that ample evaluations be made of each individual system as a whole, with the customer assuming full responsibility for decisions on the propriety of application. Mitsubishi Electric does not accept responsibility for the propriety of application.
- 6. The products described in these materials, with the exception of special mention concerning use and reliability, have been designed and manufactured with the purpose of use in general electronic machinery. Accordingly these products have not been designed and manufactured with the purpose of application in machinery or systems that will be used under conditions that can affect human life, or in machinery or systems used in social infrastructure that demand a particularly high degree of reliability. When considering the use of the products described in these materials in transportation machinery (automobiles, trains, vessels), for objectives related to medical treatment, aerospace, nuclear power control, submarine repeaters or systems or other specialized applications, please consult with Mitsubishi Electric directly or an authorized dealer.
- 7. When considering use of products for purposes other than the specific applications described in these materials, please inquire at Mitsubishi Electric or an authorized dealer.
- 8. The prior consent of Mitsubishi Electric in writing is required for any reprinting or reproduction of these materials.
- 9. Please direct any inquiries regarding further details of these materials, or any other comments or matters of attention, to Mitsubishi Electric or an authorized dealer.